Silicon P Channel MOS FET High Speed Switching

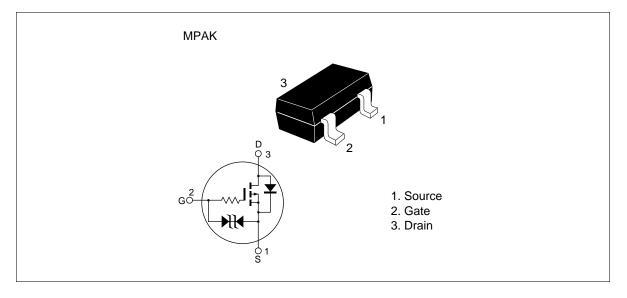
HITACHI

ADE-208-740B (Z) 3rd.Edition. June 1999

Features

- Low on-resistance $R_{DS} = 2.8 \Omega$ typ. ($V_{GS} = -10 V$, $I_D = -50 mA$) $R_{DS} = 5.7 \Omega$ typ. ($V_{GS} = -4 V$, $I_D = -50 mA$)
- 4 V gate drive device.
- Small package (MPAK)

Outline





Absolute Maximum Ratings (Ta = 25°C)

Item	Symbol	Ratings	Unit	
Drain to source voltage	V _{DSS}	-30	V	
Gate to source voltage	V _{GSS}	±20	V	
Drain current	I _D	-100	mA	
Drain peak current	Note1 D(pulse)	-400	mA	
Body-drain diode reverse drain current	I _{DR}	-100	mA	
Channel dissipation	Pch Note 2	400	mW	
Channel temperature	Tch	150	°C	
Storage temperature	Tstg	–55 to +150	°C	

Note: 1. $PW \le 10 \ \mu s$, duty cycle $\le 1\%$

2. Value on the alumina ceramic board (12.5x20x0.7mm)

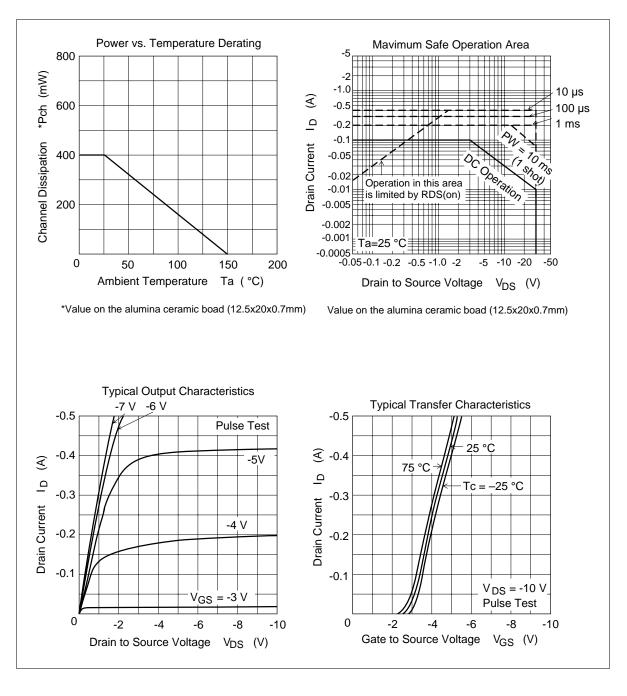
Electrical Characteristics (Ta = 25°C)

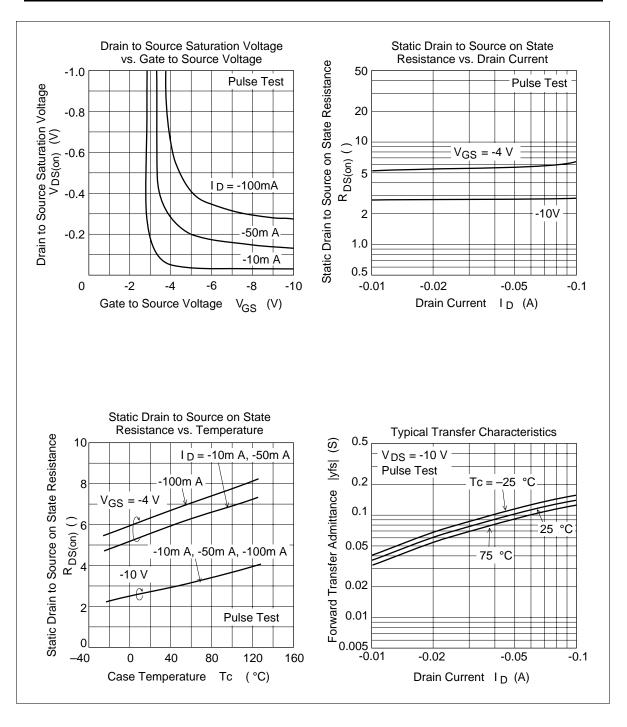
Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{(\text{BR})\text{DSS}}$	-30	_	_	V	$I_{\rm D}$ = -100 μ A, $V_{\rm GS}$ = 0
Gate to source breakdown voltage	$V_{(BR)GSS}$	±20	—	—	V	$I_{g} = \pm 100 \ \mu A, \ V_{DS} = 0$
Gate to source leak current	I _{GSS}		—	±5	μA	$V_{GS} = \pm 16 \text{ V}, \text{ V}_{DS} = 0$
Zero gate voltege drain current	I _{DSS}	_	—	-1	μA	$V_{DS} = -30 \text{ V}, \text{ V}_{GS} = 0$
Gate to source cutoff voltage	$V_{\text{GS(off)}}$	-1.3	_	-2.3	V	$I_{\rm D} = -10 \mu A, V_{\rm DS} = -5 V$
Static drain to source on state		—	2.8	3.3	Ω	I_D = -50 mA, V_{GS} = -10 V ^{Note 3}
resistance	$R_{\text{DS(on)}}$	—	5.7	7.9	Ω	I_{D} = -50 mA, V_{GS} = -4 V ^{Note 3}
Forward transfer admittance	y _{fs}	68	105	—	mS	$I_{\rm D}$ = -50 mA, $V_{\rm DS}$ = -10 V ^{Note 3}
Input capacitance	Ciss	—	25	—	pF	V _{DS} = -10 V
Output capacitance	Coss	—	20	—	pF	$V_{GS} = 0$
Reverse transfer capacitance	Crss	—	8	—	pF	f = 1 MHz
Turn-on delay time	t _{d(on)}	—	10	—	ns	$I_{\rm D}$ = -50mA, $V_{\rm GS}$ = -10 V
Rise time	t,	—	15	—	ns	$R_L = 200\Omega$
Turn-off delay time	t _{d(off)}	_	40	_	ns	
Fall time	t _f		45	_	ns	

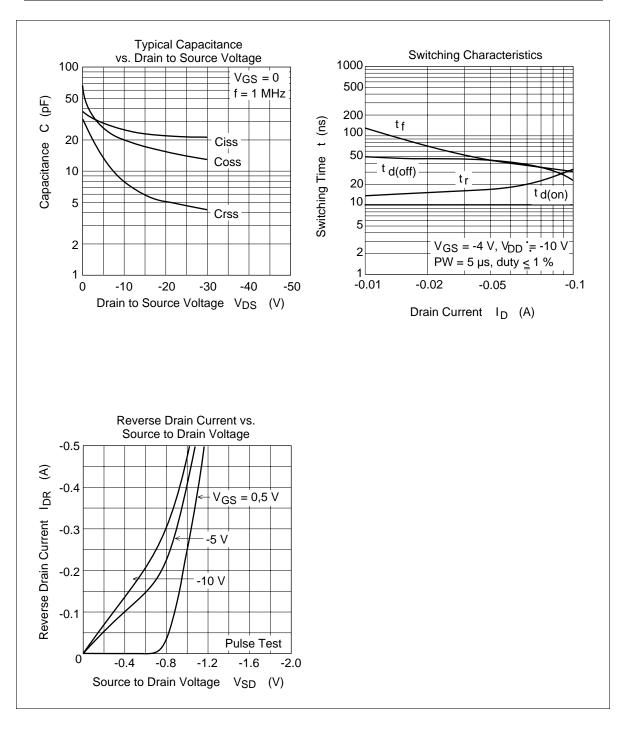
Note: 3. Pulse test

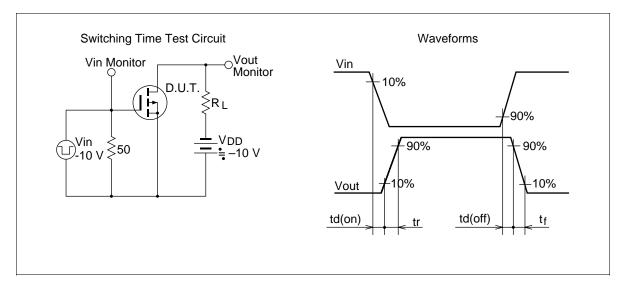
4. Marking is AP

Main Characteristics









Unit: mm

Package Dimensions

0.65 + 0.1 - 0.3 $0.4 \stackrel{+ 0.10}{- 0.05}$ $0.16 \stackrel{+ 0.10}{- 0.06}$ **2.8**^{+0.2} -0.6 0 ~ 0.1 1.5 0.95 0.45 $0.65^{+0.1}_{-0.3}$ 0.45 0.95 1.9 2.95^{+0.2}_{-0.2} 0.3 $1.1^{+0.2}_{-0.1}$ Hitachi Code MPAK EIAJ SC-59 JEDEC TO-236Mod.

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